Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/672,415	HUNTER, WENDY F.	
Examiner	Art Unit	
Douglas Q. Tran	2625	

SEARCHED				
Class	Subclass	Date	Examiner	
Class	Subclass 1.18 1.13 1.6 1.17 501 504 504 1.17 451 451 451 451	5/20/076		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
Sa	me as	above	,		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
NPL (IEEE)	5/20/06	add		
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